

## Product description

# uniqprobe™ uniform quality

## SPM probe – Soft Contact mode

The NANOSENSORS™ uniqprobe combines the well-known features of the other NANOSENSORS™ AFM probe series such as high application versatility and compatibility with most commercial SPMs with the additional advantage of a strongly reduced dispersion of force constant and resonance frequency. The unsurpassed uniformity of the mechanical characteristics of the uniqprobe series is particularly important for applications, where a large number of AFM probes with known and near identical force constants or resonance frequencies are needed. The sensors of the uniqprobe series are especially adapted for molecular biology, biophysics and quantitative nano-mechanical studies.

The reflective gold coating deposited on the detector side of the AFM cantilever covers only the free end above where the AFM tip is located. Main advantages of the uniqprobe coating are considerably less AFM cantilever bending and reduced drift particularly for measurements in liquid environments.

NANOSENSORS™ qp-SCONT AFM probes are designed for contact mode AFM imaging in air or liquid environments. The SCONT type features a very low force constant offering the possibility of contact mode measurements on soft biological materials with high sensitivity.

### The AFM probe offers unique features:

- small dispersion of force constant and resonance frequency
- typical AFM tip height 7µm
- typical AFM tip radius of curvature smaller than 10nm
- stress free AFM cantilevers with considerably less bending
- AFM tip and AFM cantilevers are made of a quartz-like material
- reduced drift for applications in liquid environments
- AFM tip repositioning accuracy of better than  $\pm 8 \mu\text{m}$  (in combination with [Alignment Chip](#))
- chemically inert

This AFM probe features alignment grooves on the back side of the holder chip. These grooves fit to the NANOSENSORS Alignment Chip.

### Cantilever data:

Property	Nominal Value	Specified Range
Resonance Frequency [kHz]	11	8 - 13
Force Constant [N/m]	0.01	0.006 - 0.015
Length [ $\mu\text{m}$ ]	125	120 - 130
Mean Width [ $\mu\text{m}$ ]	34	32 - 36
Thickness [nm]	350	320 - 380

### Order codes and shipping units:

Order Code	AFM probes per pack
qp-SCONT-10	10
qp-SCONT-20	20
qp-SCONT-50	50

### Special handling information for NANOSENSORS™ uniprbes

Due to their unique geometry the tips of the uniprbes are more susceptible to tip damage by electrostatic discharge (ESD) than other Silicon-SPM-Probes.

Electric fields near the probe chip may lead to field evaporation which can blunt the tip apex of the probe tip. Therefore the NANOSENSORS™ uniprbes are shipped in specially designed ESD-safe chip carriers.

NANOSENSORS™ recommends to their customers to take appropriate precautions to avoid tip damage due to electrostatic discharge when handling the probes. This can for example be done by using anti-electrostatic mats, wrist bands and tweezers.

